TOSHIBA BIPOLAR LINEAR INTEGRATED CIRCUIT SILICON MONOLITHIC

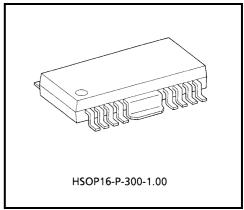
TA8430AF

STEPPING MOTOR DRIVER IC

The TA8430AF is 2 Phase Bipolar Stepping Motor Driver IC designed especially for low operating voltage use FDD and other portable equipments.

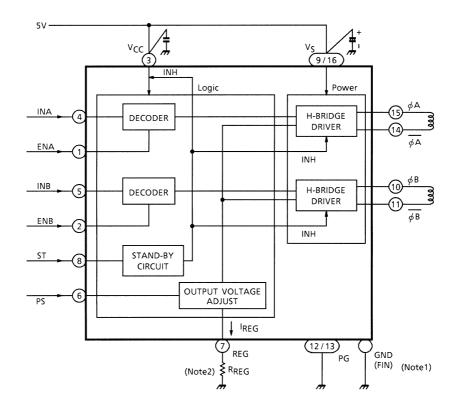
FEATURES

- 2 Phase Bipolar Stepping Motor Driver
- Low Voltage Use : V_{CC opr} = 4 V (Min.)
- Power Save and Stand-by Mode available ICC stand-by ≤ 100 μA
- Built-in Punch Through Current Restriction Circuit
- 1, 2 and 1–2 Phase Excitation Drive available
- C-MOS Compatible Inputs (INA, INB, PS, ST)
- Output Current up to 400 mA (AVE) and 600 mA (PEAK)
- Sealed in PFP 16 SM Package
- HEAT SINK is connected with GND with low impedance.



Weight : 0.50 g (Typ.)

BLOCK DIAGRAM



- Note 1: GND terminal of 12 / 13 connect to FIN.
- Note 2: Output Voltages, appeared at ϕA , $\overline{\phi} A$, ϕB and $\overline{\phi} B$, are adjusted by R_{reg} when Power Save function is selected.
- Note 3: Utmost care is necessary in the design of the output line, V_{CC}, V_S and GND line since IC may be destroyed due to short-circuit between outputs, air contamination fault, or fault by improper grounding.

PIN No.	SYMBOL	FUNCTION
1	ENA	A channel enable
2	ENB	B channel enable
3	V _{CC}	Supply voltage
4	INA	A channel reciprocal switching
5	INB	B channel reciprocal switching
6	PS	Energy-saving signal input
7	REG	Output voltage setting
8	ST	Stand-by signal input
9	VS	Supply voltage
10	φΒ	B output
11	φB	B output
12	PG	Power supply GND connection
13	PG	Power supply GND connection
14	φA	Ā output
15	φA	A output
16	VS	Supply voltage
Fin	GND	GND connection

PIN FUNCTION

FUNCTION

INPUT				OUTPUT				
ST	EN	PS	IN	φ	φ	UPPER SIDE SATURATION VOLTAGE		
Н	Н	L	L	L	Н	$V_{S} - V_{CE}$ (SAT) U		
Н	Н	L	Н	Н	L	V _S –V _{CE} (SAT) U		
Н	Н	Н	L	L	Н	V _{REG} (Note)		
Н	Н	Н	Н	Н	L	V _{REG} (Note)		

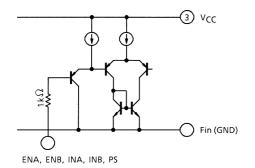
Note: V_{REG} is a voltage appeared at PIN (7) and its value becomes approximately equal to V_{OUT} in power operation period.

ST	ENA	ENB	$\phi A, \overline{\phi A}$ $\phi B, \overline{\phi B}$		MODE	
Н	L	Н	∞ ENABLE		OPERATION	
Н	Н	L	ENABLE	8	OPERATION	
Н	Н	Н	ENABLE	ENABLE	OPERATION	
L	Х	Х	8	8	STAND-BY	

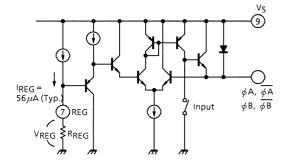
X: Don't Care

High Impedance ∞:

INPUT STEP CIRCUIT DIAGRAM



VREG OUTPUT CIRCUIT DIAGRAM

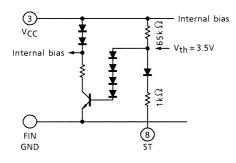


VREG output voltage can be selected with RREG exterior resistance.

If V_{REG} is not used (as in the case of double-phase magnetization), use pin (7) in the open position. (Do not connect to V_{CC} or GND pins.)

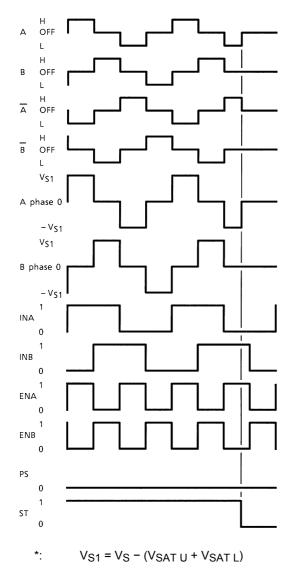
Use the following formula to obtain the output voltage. $V_{OUT} \approx V_{REG} \approx R_{REG} \times 56 \times 10^{-6}$

STAND-BY CIRCUIT DIAGRAM

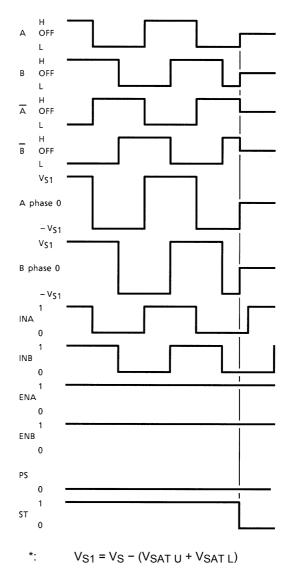


TIMING CHART

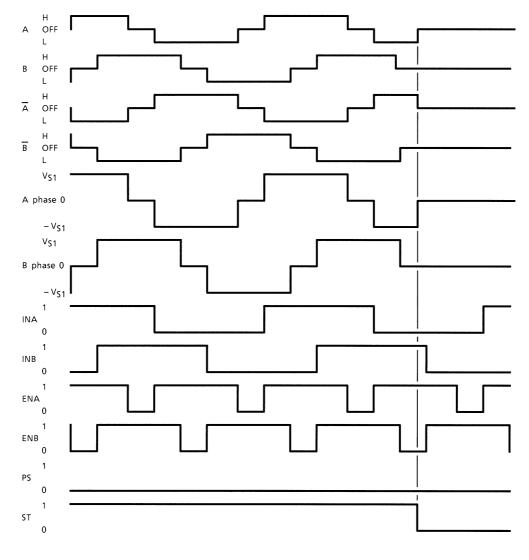
Single-phase magnetization



Double-phase magnetization

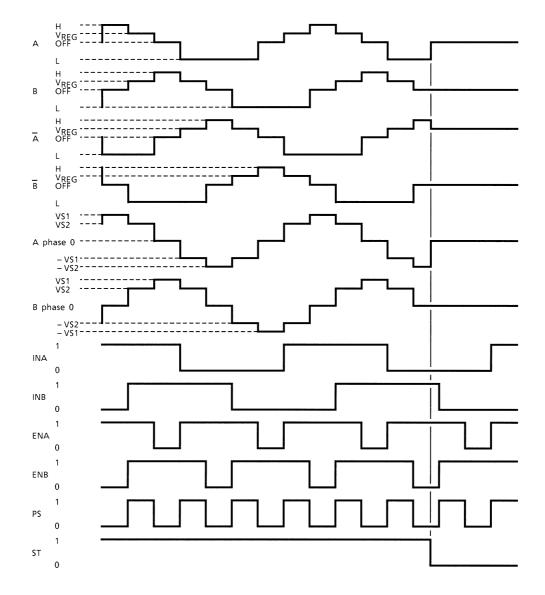


Single- / double-phase magnetization



*:
$$V_{S1} = V_S - (V_{SAT U} + V_{SAT L})$$

Single- / double-phase magnetization (with energy-saving function)



 $V_{S1} = V_S - (V_{SAT U} + V_{SAT L})$ $V_{S2} = V_{REG} - V_{SAT L}$

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT	
Supply Voltage	V _{CC}	8.0	v	
Supply Voltage	VS	8.0		
Output Current	I _{O (MAX.)}	±600	mA	
	I _{O (AVE.)}	±400		
Input Voltage	V _{IN} , V _{PS} V _{ST} , V _{EN}	GND-0.4~V _{CC} + 0.4	V	
Power Dissipation	P _D (Note)	1.4	W	
Operating Temperature	T _{opr}	-40~85	°C	
Storage Temperature	T _{stg}	-55~150	°C	

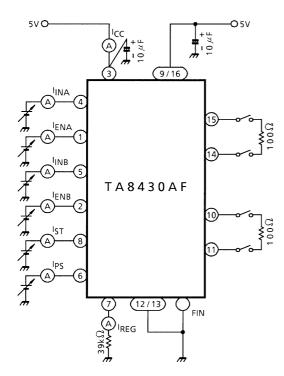
Note: 60 × 30 × 1.6 mm PCB occupied in excess of 50% of copper area, mounting.

ELECTRICAL CHARACTERISTICS (Ta = 25° C, V_{CC} = 5 V, V_S = 5 V, ST = 5 V, PS = 0 V, EN = 5 V)

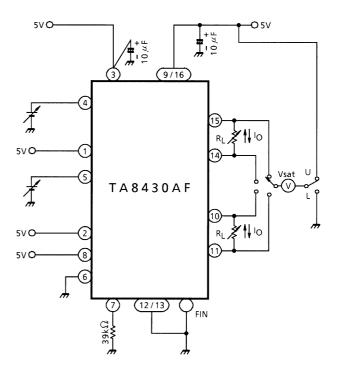
CHARACTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION		MIN	TYP.	MAX	UNIT
	I _{CC1}		Output open		_	14	20	
	I _{CC2}	1	Output open, PS = 5 V		_	14	20	
			Output open	ENA = 0 V, ENB = 5 V		9	15	mA
Supply Current	ICC3			ENA = 5 V, ENB = 0 V	—			
	last		Output open, PS = 5 V	ENA = 0 V, ENB = 5 V		9	15	
	I _{CC4}			ENA = 5 V, ENB = 0 V	—			
	I _{CC5}		ST = 0 V		20	65	110	μA
	V _{INH}		(4), (5) pin Source type		3.5	_	V _{CC}	
	V _{INL}	- 1 -			GND		1.7	
Input Voltage	V _{ENH} , V _{PSH}		(1), (2), (6), (8) pin Source type		3.5	_	V _{CC}	V
input voltage	V _{STH}				0.0		*UU	v
	V _{ENL} , V _{PSL}				GND	_	1.7	
	V _{STL}				OND			
	I _{INH}		V _{IN} = 3.5 V	(4), (5) pin	_	0	0.1	
	I _{INL}		V _{IN} = 0 V	(1), (0) pill	_	0.25	5.0	
Input Current	I _{ENH} , I _{PSH}	1	V _{EN} = V _{PS} = 3.5 V	(1), (2), (6) pin	_	0	0.1	μA
	I _{ENL} , I _{PSL}		V _{EN} = V _{P S} = 0V		—	0.25	5.0	μ, ,
	I _{STH}		V _{ST} = 3.5 V	(8) pin	_	0	0.1	
	ISTL		$V_{ST} = 0 V$	(•) Piii	—	65	110	

CHARACTERISTIC		SYMBOL	TEST CIR- CUIT	TEST CONDITION		MIN.	TYP.	MAX.	UNIT
Saturation Voltage		V _{SAT U1}			I _{OUT} = 100 mA		0.8	-	V
		V _{SAT U2}	2		I _{OUT} = 400 mA		0.9	1.2	
		V _{SAT L1}	2		I _{OUT} = 100 mA		0.1	—	
		V _{SAT L2}			I _{OUT} = 400 mA		0.2	0.4	
Output Control Linn	Output Control Linnor Voltage			R _{REG} = 39 kΩ	I _{OUT} = 100 mA		2.0	—	v
Output Control Upper Voltage		V _{REG} 2			I _{OUT} = 400 mA		1.9	—	
Control Circuit Output Current		I _{REG}	1	—		41	56	71	μA
Diode Forward Voltage		V _{FU}	- 3	IF = 400 mA			1.5	2.0	V
		V _{FL}	Ŭ				1.0	2.0	
Operating Supply V Range	Operating Supply Voltage Range		_	_		4.0	_	6.0	V
	$IN_{-\phi}$	- t _{pLH}		– RL = 8.2 Ω CL = 15 pF			4.5	—	
	$EN_{-\phi}$						3	-	
	$PS_{-\phi}$						4.5	_	
Propagation	$ST_{-\phi}$						10	_	
Delay Time	$IN_{-\phi}$						0.1	_	μs
	$EN_{-\phi}$	t				—	10	—	
	PS- _φ	t _{pHL}					0.2	_	
	$ST_{-\phi}$						5	—	

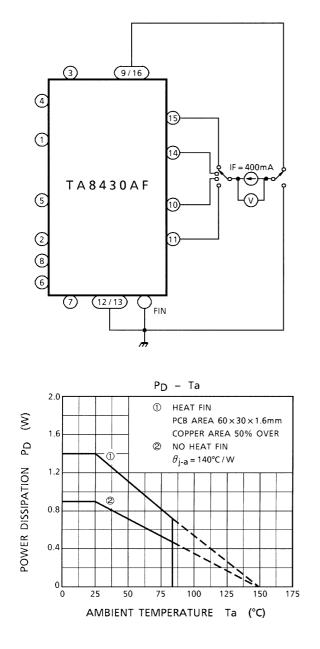
TEST CIRCUIT 1

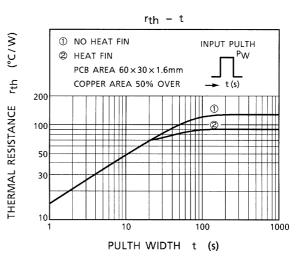


TEST CIRCUIT 2



TEST CIRCUIT 3





PACKAGE DIMENSIONS

HSOP16-P-300-1.00

Unit : mm

3.4±0.1 **9** || || || || || 6.4±0.2 9.6±0.3 H 1 + 1 H HHHН Н 8 1 0.4±0.1 1.0 1.0TYP 2.5 13.5MAX 13.0±0.2 2.85MAX 0.25 ± 0.1 -0.052.3±0.2 0.1 - 0.05 0.92±0.2

Weight : 0.50 g (Typ.)

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